


<b>Search Notes</b>  	<b>Application/Control No.</b>  10630223	<b>Applicant(s)/Patent Under Reexamination</b>  MICHON ET AL.
	<b>Examiner</b>  S. Devi, Ph.D.	<b>Art Unit</b>  1645

SEARCHED			
Class	Subclass	Date	Examiner
424	194.1, 193.1, 244.1, 831, 234.1, 184.1	May, 08	SD
536	123.1	May, 08	SD
514	23	May, 08	SD

SEARCH NOTES		
Search Notes	Date	Examiner
PALM - ODP rechecked.	May, 08	SD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner